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Birth September 17, 1968 – Alesd, Romania

Affiliation Innovations for High Performance
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Professional appointments

August 2005 - Present	Team Leader - "Off-Line Characterization" – IHP GmbH
August 2002 - July 2005	Postdoctoral research fellow at Max-Planck-Institut for metal research, Stuttgart, Germany

Education

January 1999 - July 2002	Ph.D. - Research Center Jülich, Germany
August 1995 - December 1999	Researcher at Faculty of Physics, „Babes-Bolyai“ University, Cluj-Napoca, Romania
October 1994 - July 1995	Master study at Faculty of Physics, „Babes-Bolyai“ University, Cluj-Napoca, Romania
October 1989 - March 1994	Undergraduate school student at Faculty of Physics, „Babes-Bolyai“ University, Cluj-Napoca, Romania

Field of interest

Analytical methods for surface and interface analysis
(SIMS, ToF-SIMS, XPS, Auger, SEM, TEM, VPD ICP-MS)